



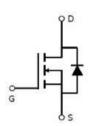
MJ N-Channel Enhancement Mode Power MOSFET

Description

The MJ30H11BK uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. It can be used in a wide variety of applications.

General Features

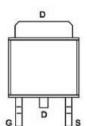
- ♦ Vps =30V.lp =110A $R_{DS(ON)}$ <2.6m Ω (typical) @ V_{GS}=10V $R_{DS(ON)}$ <4.5m Ω (typical) @ V_{GS}=4.5V
- ◆ High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high Eas
- Excellent package for good heat dissipation
- ◆ Special process technology for high ESD capability



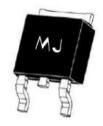


Application

- DC/DC converters
- Synchronous Rectifier







TO-252-2L top view

100% UIS TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ30H11BK	MJ30H11BK	TO-252-2L	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (Tc =25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	30	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	lo	110	А
Drain Current-Continuous(Tc =100℃)	ID(100°C)	77.8	А
Pulsed Drain Current	IDM	440	А
Maximum Power Dissipation	Po	115	W
Derating factor	PD	0.77	W/°C
Single pulse avalanche energy (Note 5)	Eas	300	mJ
Operating Junction and Storage Temperature Range	Тл,Тѕтс	-55 To 175	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	Rejc	1.36	°C/W
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Electrical Characteristics (TA =25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	'					
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V I _D =250µA	30	-	-	V
Zero Gate Voltage Drain Current	loss	V _{DS} =30V,V _{GS} =0V	-	-	1	μΑ
Gate-Body Leakage Current	lgss	V _{DS} =±20V,V _{DS} =0V	_	-	±100	nA
On Characteristics (Note 3)	'					
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250µA	1	1.5	2.2	V
Davin Course On Otata Davintana		Vgs=10V, ID=20A	-	2.6	4.0	mΩ
Drain-Source On-State Resistance	Rds(on)	V _{GS} =4.5V, I _D =20A	-	4.5		
Forward Transconductance	grs	V _{DS} =5V,I _D =20A	20	-	-	S
Dynamic Characteristics (Note 4)	1					
Input Capacitance	Clss		-	3009	-	PF
Output Capacitance	Coss	V _{DS} =15V,V _{GS} =0V F=1.0MHz	-	451	_	PF
Reverse Transfer Capacitance	Crss		-	403	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	11	-	nS
Turn-on Rise Time	tr	VDD=15V,ID=20A	-	14	-	nS
Turn-Off Delay Time	t _{d(off)}	Vgs=10V,Rgen=3Ω	_	36	-	nS
Turn-Off Fall Time	tr		_	12	-	nS
Total Gate Charge	Qg		_	66.3	_	nC
Gate-Source Charge	Qgs	V _{DS} =15V,I _D =20A V _{GS} =10V	_	7.0	_	nC
Gate-Drain Charge	Qgd		_	17.2	_	nC
Drain-Source Diode Characteristics		I	<u> </u>	<u> </u>	<u> </u>	
Diode Forward Voltage (Note 3)	VsD	Vgs=0V,Is=20A	_	_	1.2	V
Diode Forward Current (Note 2)	Is		_	-	110	А
Reverse Recovery Time	trr	T1-25°C 15-20^	_	29	-	nS
Reverse Recovery Charge	Qrr	TJ=25°C, IF=20A di/dt=100A/µs (Note 3)	_	32	_	nC

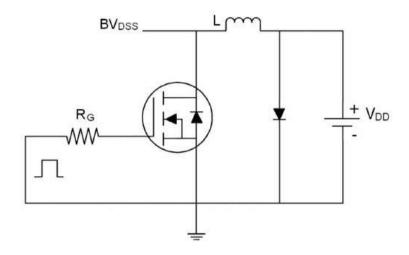
Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4 Guaranteed by design, not subject to production
- $\ensuremath{\mathfrak{T}}$ EAS condition: Tj=25°C,Vpp=15V,Vg=10V,L=0.5mH,Rg=25 Ω

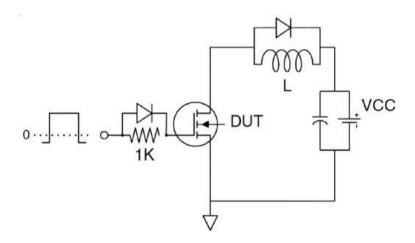




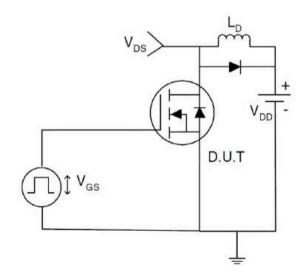
Test circuit



Eas test Circuit



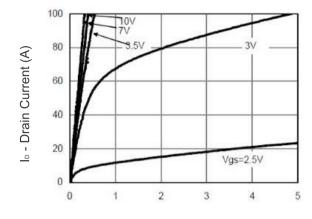
Gate charge test Circuit



Switch Time Test Circuit

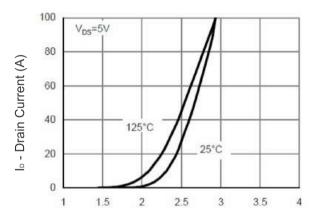


Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V)
Figure 2 Transfer Characteristics

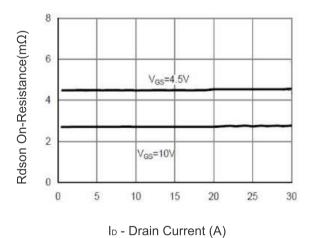
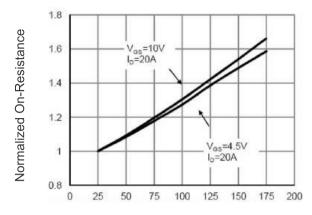


Figure 3 Rdson- Drain Current



T∍ -Junction Temperature(°C)

Figure 4 Rdson-Junction Temperature

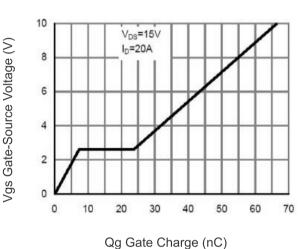
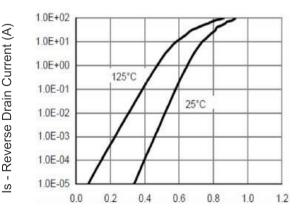


Figure 5 Gate Charge

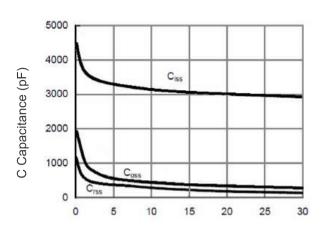


Vsd Source-Drain Voltage (V)

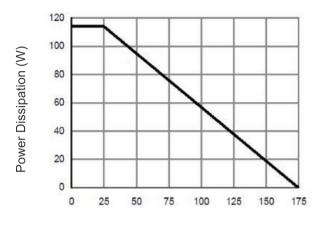
Figure 6 Source- Drain Diode Forward



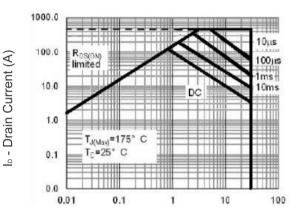




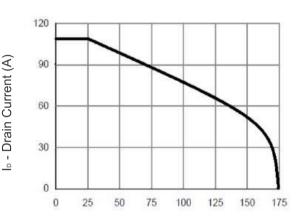
Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



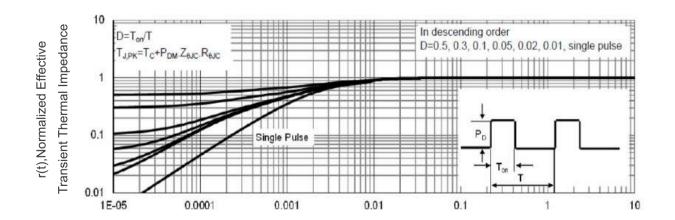
T_J -Junction Temperature(°C) Figure 9 Power De-rating



Vds Drain-Source Voltage (V)
Figure 8 Safe Operation Area



T_J -Junction Temperature(°C)
Figure 10 I_D Current Derating



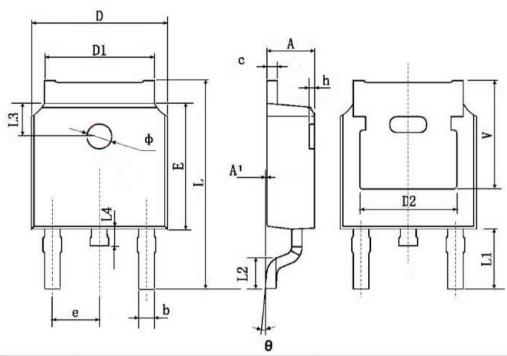
Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance



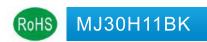


TO-252 Package Information



Cumb al	Dimensions	n Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	0.483	TYP.	0.190 TYP.	
E	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900	TYP.	0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600	TYP.	0.063	TYP.
L4	0.600	1.000	0.024	0.039
Ф	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5,350	5.350 TYP. 0.211 TYP.		TYP.





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